Application/Control No.	Applicant(s)/Patent under Reexamination	
10/680,213	FUKUOKA ET AL.	
Examiner	Art Unit	
B. Chen	1762	

SEARCHED						
Class	Subclass	Date	Examiner			
118	723E	11/13/2005	вс			
	725 729					
		-				
						

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
118	723E	11/13/2005	ВС		
	725 729				
	-				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
DATE	EXMR			
11/13/2005	вс			
	DATE			